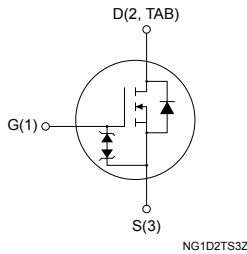
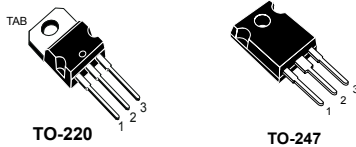


## N-channel 500 V, 300 mΩ typ., 14 A SuperMESH Power MOSFETs in TO-220 and TO-247 packages



### Features

Order code	$V_{DS}$	$R_{DS(on)}$ max.	$I_D$
STP15NK50Z	500 V	340 mΩ	14 A
STW15NK50Z			

- Extremely high dv/dt capability
- Improved ESD capability
- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitance
- Zener-protected

### Applications

- Switching applications

### Description

These high-voltage devices are Zener-protected N-channel Power MOSFETs developed using the SuperMESH technology by STMicroelectronics, an optimization of the well-established PowerMESH. In addition to a significant reduction in on-resistance, these devices are designed to ensure a high level of dv/dt capability for the most demanding applications.

#### Product status links

[STP15NK50Z](#)

[STW15NK50Z](#)

#### Product summary

Order code	STP15NK50Z
Marking	P15NK50Z
Package	TO-220
Packing	Tube
Order code	STW15NK50Z
Marking	W15NK50Z
Package	TO-247
Packing	Tube

# 1 Electrical ratings

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	500	V
$V_{GS}$	Gate-source voltage	$\pm 30$	V
$I_D$	Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$	14	A
	Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$	8.8	
$I_{DM}^{(1)}$	Drain current (pulsed)	56	A
$P_{TOT}$	Total power dissipation at $T_C = 25\text{ }^\circ\text{C}$	160	W
ESD	Gate-source human body model ( $C = 100\text{ pF}$ , $R = 1.5\text{ k}\Omega$ )	4	kV
$dv/dt^{(2)}$	Peak diode recovery voltage slope	4.5	V/ns
$T_J$	Operating junction temperature range	-50 to 150	$^\circ\text{C}$
$T_{stg}$	Storage temperature range		

1. Pulse width limited by safe operating area.

2.  $I_{SD} \leq 14\text{ A}$ ,  $di/dt \leq 200\text{ A}/\mu\text{s}$ ,  $V_{DS}(\text{peak}) < V_{(BR)DSS}$ .

**Table 2. Thermal data**

Symbol	Parameter	Value		Unit
		TO-220	TO-247	
$R_{thJC}$	Thermal resistance, junction-to-case	0.78		$^\circ\text{C}/\text{W}$
$R_{thJA}$	Thermal resistance, junction-to-ambient	62.5	50	$^\circ\text{C}/\text{W}$

**Table 3. Avalanche characteristics**

Symbol	Parameter	Value	Unit
$I_{AR}$	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_J$ max.)	14	A
$E_{AS}$	Single pulse avalanche energy (starting $T_J = 25\text{ }^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50\text{ V}$ )	300	mJ

## 2 Electrical characteristics

$T_C = 25\text{ °C}$  unless otherwise specified.

**Table 4. On/off states**

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 1\text{ mA}$ , $V_{GS} = 0\text{ V}$	500			V
$I_{DSS}$	Zero gate voltage drain current	$V_{GS} = 0\text{ V}$ , $V_{DS} = 500\text{ V}$			1	$\mu\text{A}$
		$V_{GS} = 0\text{ V}$ , $V_{DS} = 500\text{ V}$ , $T_C = 125\text{ °C}^{(1)}$			50	
$I_{GSS}$	Gate-body leakage current	$V_{DS} = 0\text{ V}$ , $V_{GS} = \pm 20\text{ V}$			$\pm 10$	$\mu\text{A}$
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 100\text{ }\mu\text{A}$	3	3.75	4.5	V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 10\text{ V}$ , $I_D = 7\text{ A}$		300	340	$\text{m}\Omega$

1. Specified by design, not tested in production.

**Table 5. Dynamic**

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$ , $V_{GS} = 0\text{ V}$	-	2260		$\text{pF}$
$C_{oss}$	Output capacitance		-	264		$\text{pF}$
$C_{riss}$	Reverse transfer capacitance		-	64		$\text{pF}$
$C_{oss\text{ eq.}}^{(1)}$	Equivalent output capacitance	$V_{DS} = 0\text{ to }400\text{ V}$ , $V_{GS} = 0\text{ V}$	-	150		$\text{pF}$
$Q_g$	Total gate charge	$V_{DD} = 400\text{ V}$ , $I_D = 14\text{ A}$ , $V_{GS} = 0\text{ to }10\text{ V}$ (see the Figure 16. Test circuit for gate charge behavior)	-	76	106 <sup>(2)</sup>	$\text{nC}$
$Q_{gs}$	Gate-source charge		-	15		$\text{nC}$
$Q_{gd}$	Gate-drain charge		-	40		$\text{nC}$

1.  $C_{oss\text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .

2. Specified by design, not tested in production.

**Table 6. Switching times**

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 250\text{ V}$ , $I_D = 7\text{ A}$ , $R_G = 4.7\text{ }\Omega$ , $V_{GS} = 10\text{ V}$ (see the Figure 15. Test circuit for resistive load switching times and Figure 20. Switching time waveform)	-	20	-	ns
$t_r$	Rise time		-	23	-	ns
$t_{d(off)}$	Turn-off delay time		-	62	-	ns
$t_f$	Fall time		-	15	-	ns

**Table 7. Source-drain diode**

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		14	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		56	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 14\text{ A}$ , $V_{GS} = 0\text{ V}$	-		1.6	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 14\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ ,	-	428		ns
$Q_{rr}$	Reverse recovery charge	$V_{DD} = 29\text{ V}$ , $T_J = 150\text{ }^\circ\text{C}$	-	4.2		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current	(see the Figure 17. Test circuit for inductive load switching and diode recovery times)	-	20		A

1. Pulse width is limited by safe operating area.
2. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%.

## 2.1 Electrical characteristics (curves)

Figure 1. Safe operating area for TO-220

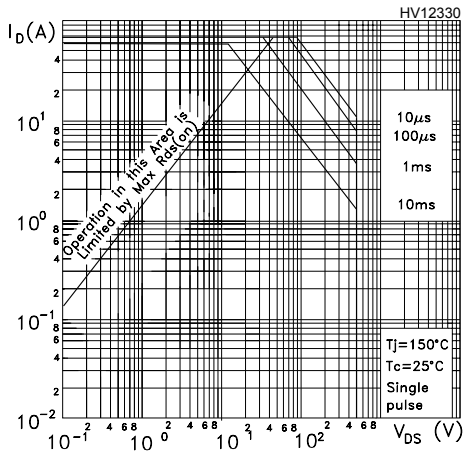


Figure 2. Normalized transient thermal impedance for TO-220

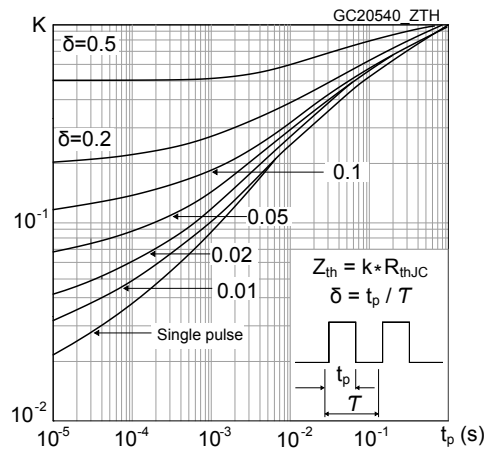


Figure 3. Safe operating area for TO-247

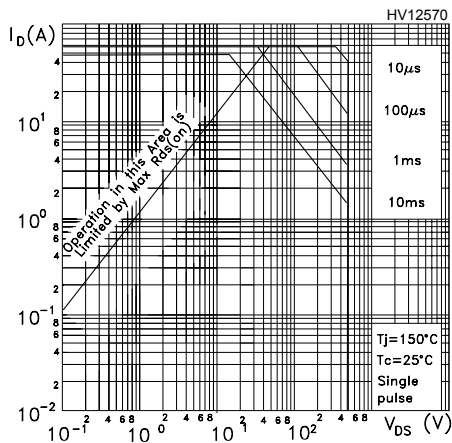


Figure 4. Normalized transient thermal impedance for TO-247

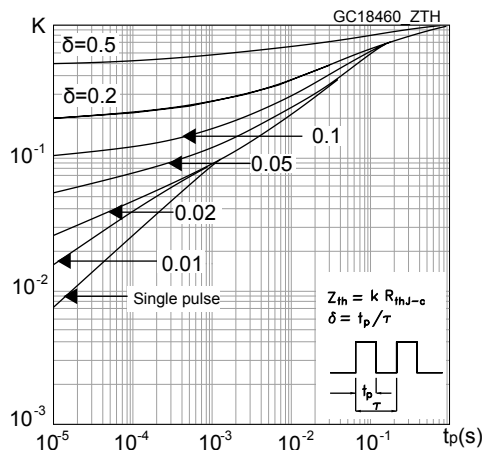


Figure 5. Typical output characteristics

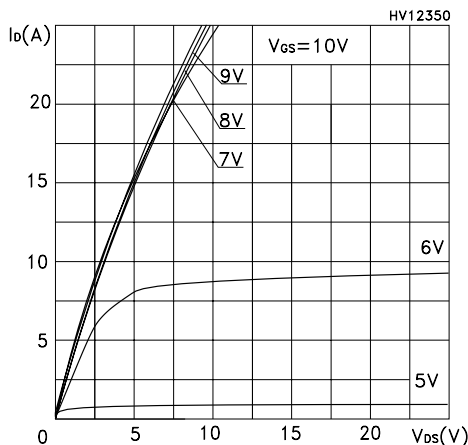


Figure 6. Typical transfer characteristics

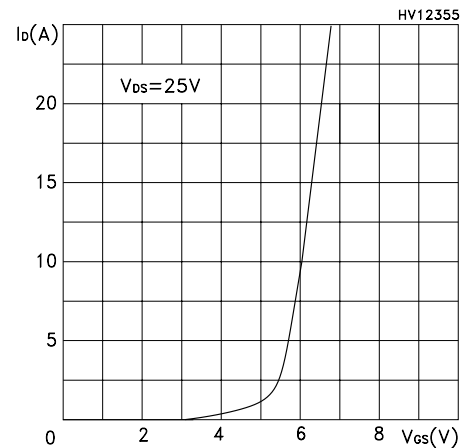


Figure 7. Typical gate charge characteristics

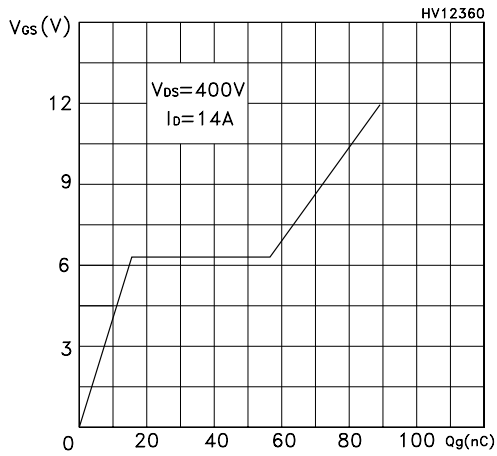


Figure 8. Typical drain-source on-resistance

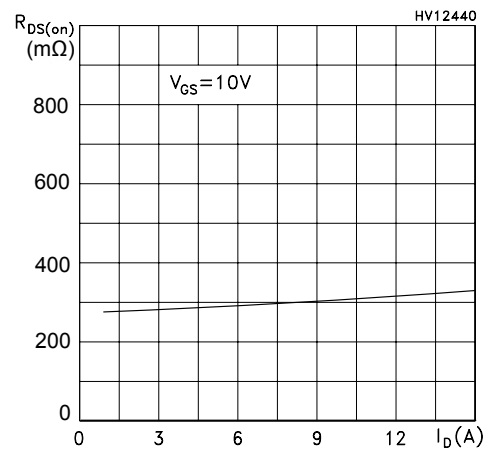


Figure 9. Typical capacitance characteristics

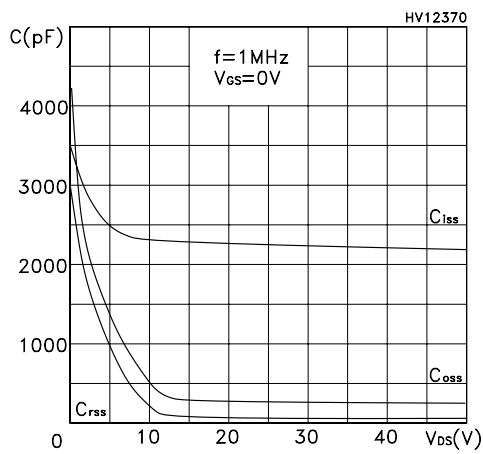


Figure 10. Normalized gate threshold vs temperature

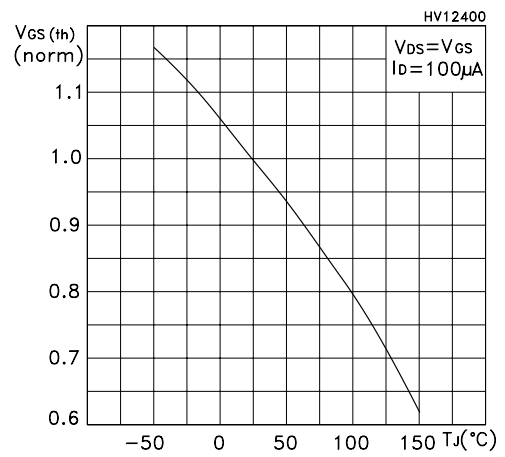


Figure 11. Normalized on-resistance vs temperature

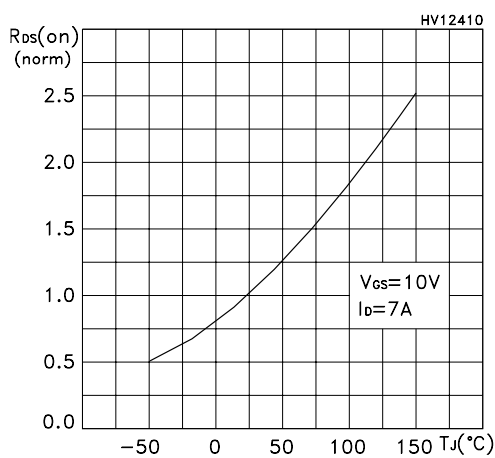


Figure 12. Normalized breakdown voltage vs temperature

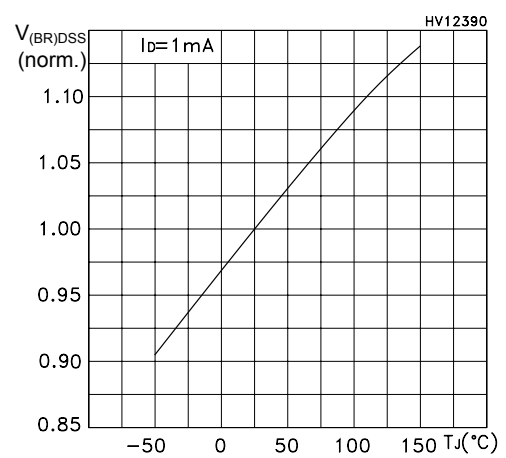


Figure 13. Maximum avalanche energy vs temperature

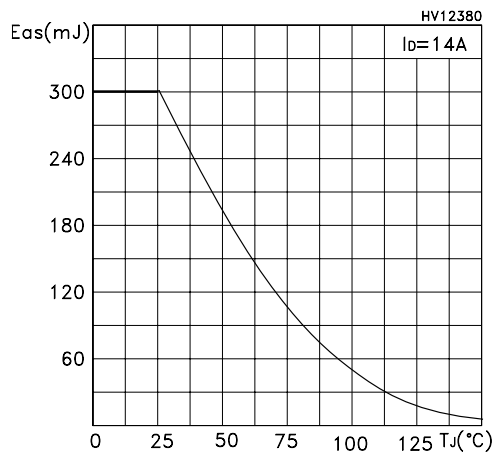
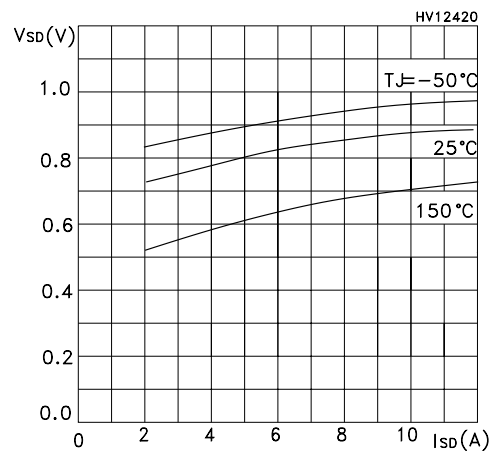
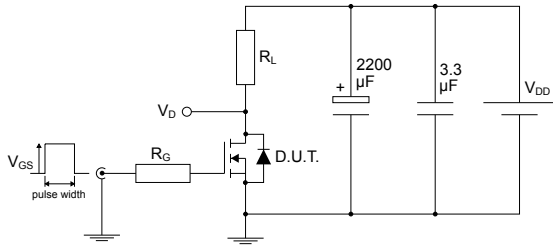


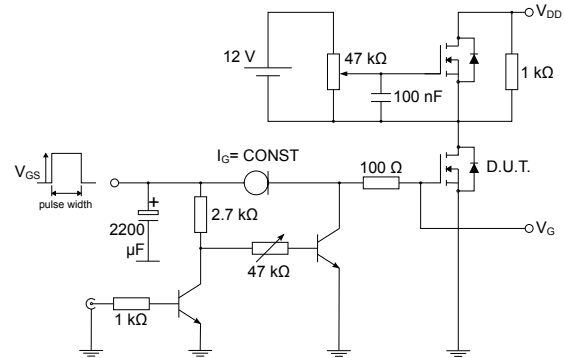
Figure 14. Typical reverse diode forward characteristics



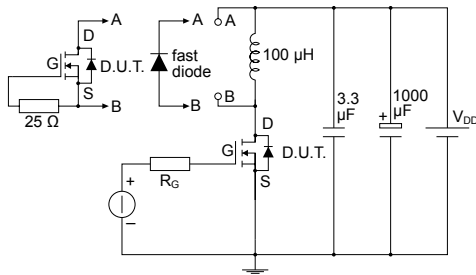
### 3 Test circuits

**Figure 15. Test circuit for resistive load switching times**


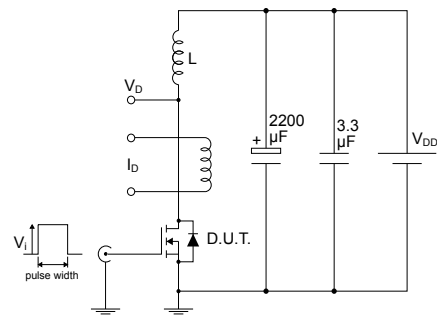
AM01468v1

**Figure 16. Test circuit for gate charge behavior**


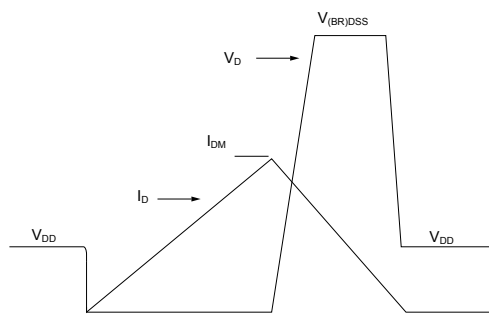
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**Figure 17. Test circuit for inductive load switching and diode recovery times**


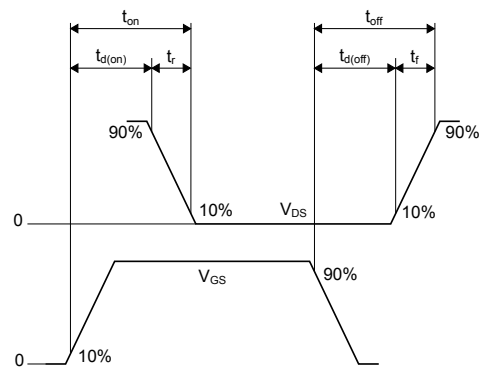
AM01470v1

**Figure 18. Unclamped inductive load test circuit**


AM01471v1

**Figure 19. Unclamped inductive waveform**


AM01472v1

**Figure 20. Switching time waveform**


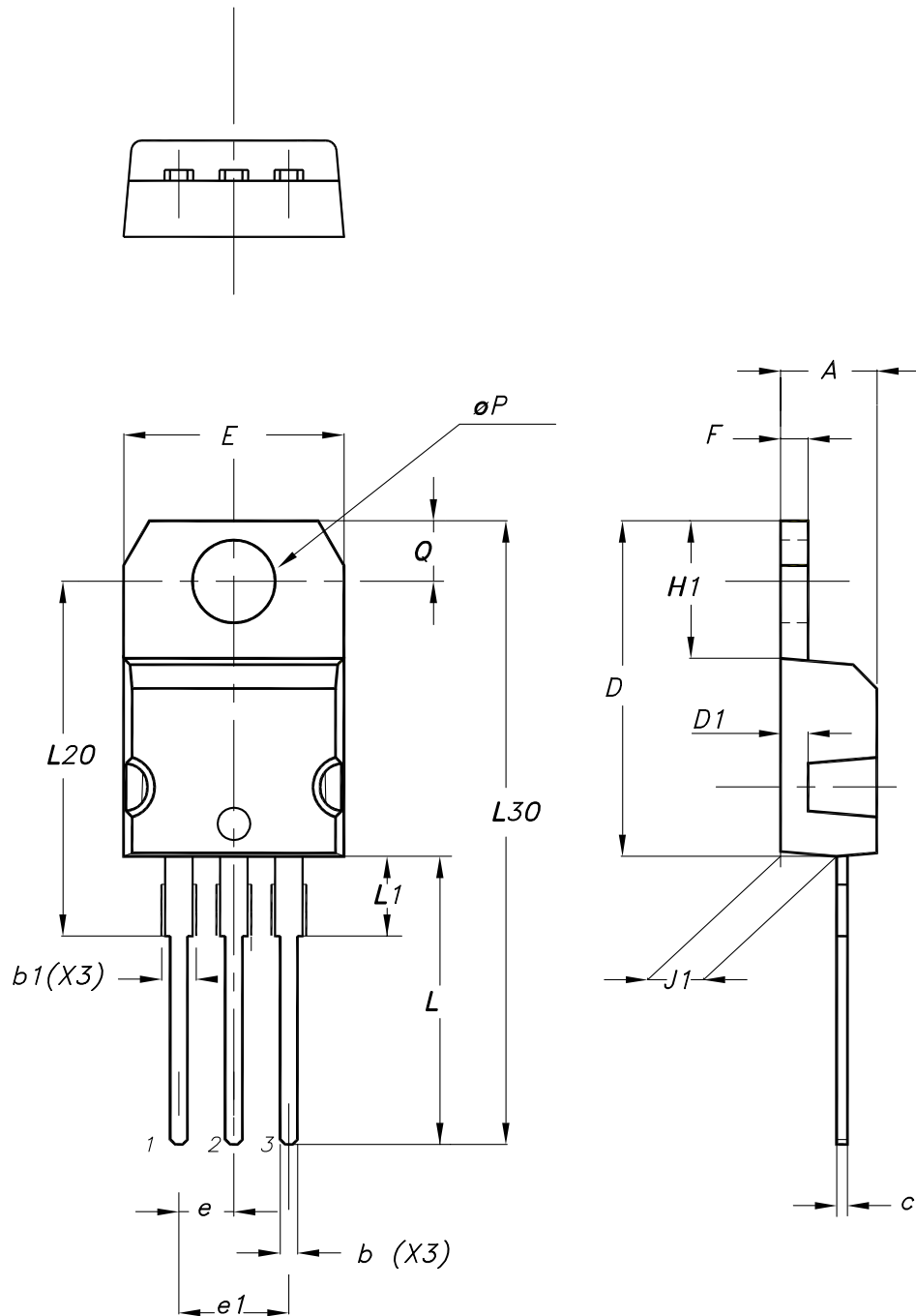
AM01473v1

## 4 Package information

To meet environmental requirements, ST offers these devices in different grades of **ECOPACK** packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions, and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

### 4.1 TO-220 type A package information

Figure 21. TO-220 type A package outline



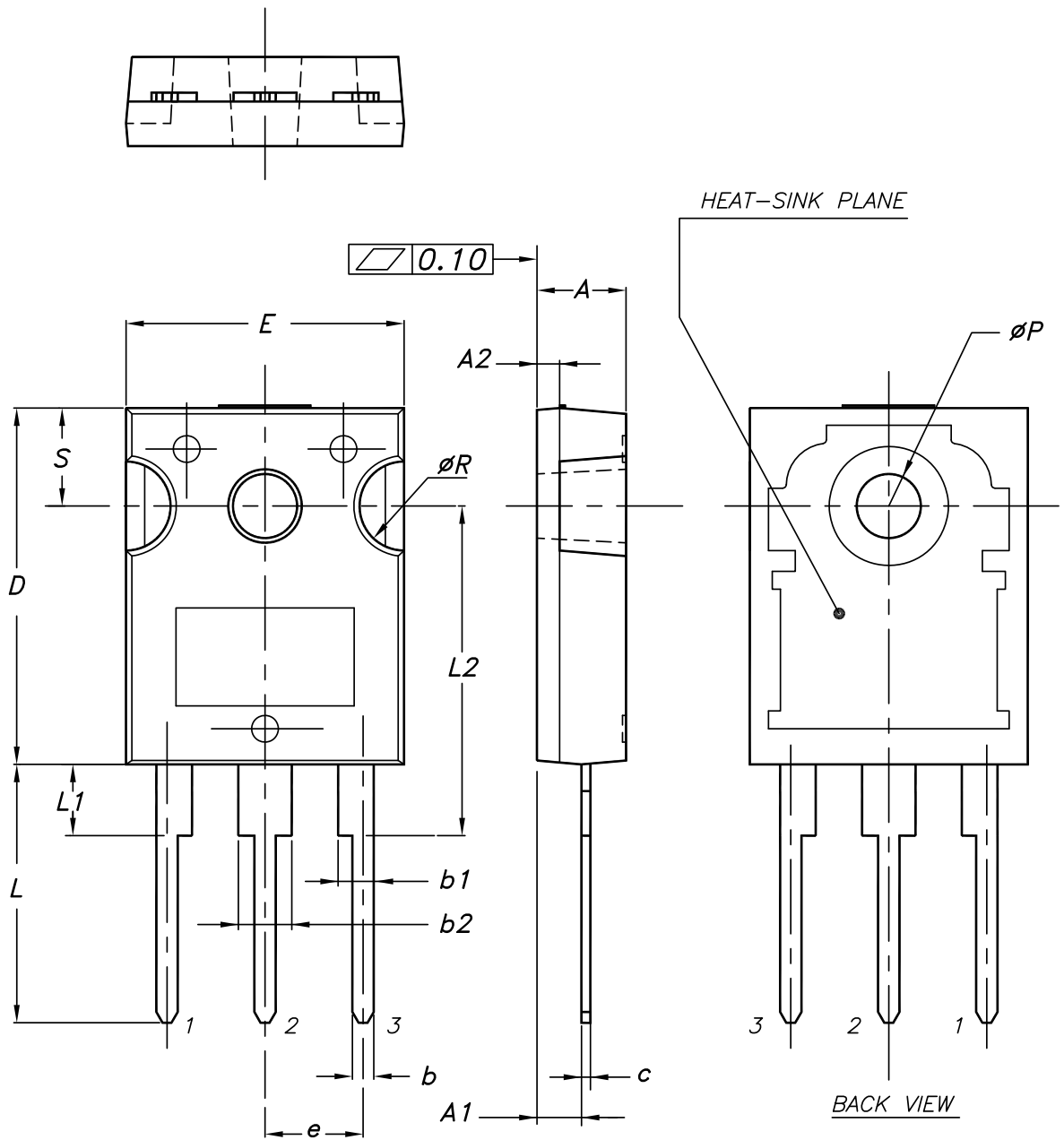
0015988\_typeA\_Rev\_24

**Table 8. TO-220 type A package mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
b	0.61		0.88
b1	1.14		1.55
c	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10.00		10.40
e	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13.00		14.00
L1	3.50		3.93
L20		16.40	
L30		28.90	
øP	3.75		3.85
Q	2.65		2.95
Slug flatness		0.03	0.10

## 4.2 TO-247 package information

Figure 22. TO-247 package outline



0075325\_11

**Table 9. TO-247 package mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.85		5.15
A1	2.20		2.60
A2		1.27	
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

## Revision history

**Table 10. Document revision history**

Date	Version	Changes
21-Jun-2004	2	Complete version
20-Jul-2006	3	New template, no content change
05-Jan-2007	4	Modified unit on <i>On/off states</i>
09-Feb-2026	5	The part numbers STB15NK50Z, STB15NK50Z-1 and STP15NK50ZFP have been removed and the document has been updated accordingly. Updated <a href="#">Section 4: Package information</a> . Minor text changes.



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